

Search Notes

Application/Control No.

10/027,163

Examiner

Djenane M. Bayard

Applicant(s)/Patent under
Reexamination

COUTS ET AL.

Art Unit

2141

SEARCHED

Class	Subclass	Date	Examiner
709	204	8/25/2005	DB
709	206	8/25/2005	DB

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	8/25/2005	DB